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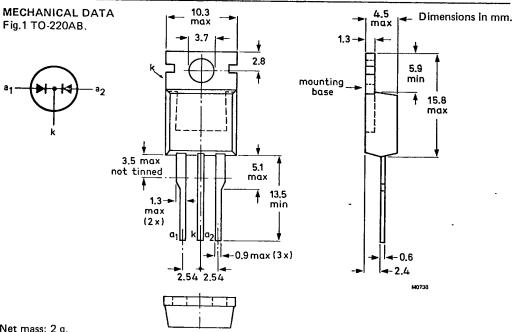
SCHOTTKY-BARRIER DOUBLE RECTIFIER DIODES

7-03-19

Low-leakage platinum-barrier double rectifier diodes in plastic envelopes, featuring low forward voltage drop, low capacitance, and absence of stored charge. They are intended for use in switched-mode power supplies and high-frequency circuits in general, where both low conduction losses and zero switching losses are important. Their single chip (monolithic) construction allows both diodes to be paralleled without the need for derating. They can also withstand reverse voltage transients and have guaranteed reverse avalanche surge capability. The series consists of common-cathode types.

QUICK REFERENCE DATA

Per diode, unless otherwise stated			PBYR2035CT	2040CT	2045CT	
Repetitive peak reverse voltage	VRRM	max.	35	40	45	٧
Output current (both diodes conducting)	Io	max.		20	1	A
Forward voltage	٧F	<			٧	
Junction temperature	τ_j	max.			οС	



Note: the exposed metal mounting base is directly connected to the common cathode. Accessories supplied on request: see data sheets Mounting instructions and accessories for TO-220 envelopes.

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RATINGS

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Limiting values in accordance with the Absolute Maximum System (IEC 134).

Currently values in accordance with the Absolute Maxim	idili Oyse	on (120 104).	*		
Voltages (per diode)		PBYR2035CT	2040CT	2045CT	
Repetitive peak reverse voltage	VRRM	max, 35	40	45	٧
Crest working reverse voltage	VRWM	max. 35	40	45	V
Continuous reverse voltage	V _R	max. 35	40	45	٧
Currents					
Average forward current square wave; δ = 0.5; up to T _{mb} = 135 °C (note 1) per diode per device	lF(AV)	max. max.	10 20	=	A A
Repetitive peak forward current per diode (note 1) $t_p = 25 \mu s$; $\delta = 0.5$; $T_{mb} = 135 ^{O}C$	IFRM	max.	20)	Α
Non-repetitive peak forward current (per device) half sinewave; T _j = 125 °C prior to surge; with reapplied V _{RWM max} t=10ms t=8.3ms	I _{FSM} I _{FSM}	max. max,	139 150		A A
I ² t for fusing (t=10ms; per device)	12 t	max.	93	3	A²s
Reverse surge current (per diode) $t_p = 2 \mu s; \delta = 0.001$ $t_p = 100 \mu s$ Temperatures	IRRM IRSM	max. max.	1.0 1.0		A A
Storage temperature	T _{stg}		-65 to +175	5	οс
Junction temperature	Tj	max.	150)	οС
CHARACTERISTICS (per diode)	•			-	
Forward voltage (note 2) $I_F=10A$; $T_j=125$ °C $I_F=20A$; $T_j=125$ °C $I_F=20A$; $T_j=25$ °C	VF VF VF	< < <	0.5 0.7 0.8	2	> > >
Reverse current					
V _R =V _{RWM max} ; T _j =125 °C V _R =V _{RWM max} ; T _j = 25 °C	I _R	< <	1 <u>!</u> 0.		mA mA

Notes:

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^{1.} At rated reverse voltage V_R .

^{2.} Measured under pulse conditions to avoid excessive dissipation.

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THERMAL RESISTANCE									
Fre	From junction to mounting base (both diodes conducting)				R _{th j-mb}	= _	1.0		K/W
Fr	om junction to mounting base (per diode)				R _{th j-mb}	=	2.0		K/W
Influence of mounting method T-03-19									
1.	1. Heatsink-mounted with clip (see mounting instructions)								
Th	ermal resistance from mounting base to he	atsink							
a.	with heatsink compound				R _{th mb-h}	=	0.5		K/W
b.	with heatsink compound and 0.06mm mainsulator	ximum	mica		R _{th mb-h}	=	1.4		K/W
c.	with heatsink compound and 0.1mm max insulator (56369)	imum m	nica		R _{th mb-h}	=	2.2		K/W
d.	with heatsink compound and 0.25mm ma alumina insulator (56367)	ximum			R _{th mb-h}	=	0.8		K/W
e.	without heatsink compound				R _{th mb-h}	=	1.4		K/W
2.	Free air operation								
The quoted value of R _{th j-a} should be used only when no leads of other dissipating components run to the same tie point. Thermal resistance from junction to ambient in free air:									

MOUNTING INSTRUCTIONS

 The device may be soldered directly into the circuit, but the maximum permissible temperature of the soldering iron or bath is 275 °C; the heat source must not be in contact with the joint for more than 5 seconds. Soldered joints must be at least 4.7mm from the seal.

Rth j-a

- 2. The leads should not be bent less than 2.4mm from the seal, and should be supported during bending. The bend radius must be no less than 1.0mm.
- 3. Mounting by means of a spring clip is the best mounting method because it offers:
 - a. a good thermal contact under the crystal area and slightly lower $R_{\mbox{th}}$ mb-h values than does screw mounting.
 - b. safe isolation for mains operation.

mounted on a printed circuit board at any device lead

length and with copper laminate on the board

- However, if a screw is used, it should be M3 cross-recess pan head. Care should be taken to avoid damage to the plastic body.
- 4. For good thermal contact heatsink compound should be used between mounting base and heatsink. Values of R_{th mb-h} given for mounting with heatsink compound refer to the use of a metallic-oxide loaded compound. Ordinary silicone grease is not recommended.
- Rivet mounting (only possible for non-insulated mounting).
 Devices may be rivetted to flat heatsinks; such a process must neither deform the mounting tab, nor enlarge the mounting hole.

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SQUARE-WAVE OPERATION

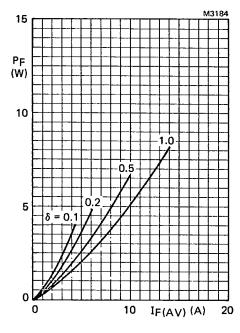


Fig.2 Forward current power rating; per diode.

$$\delta = \frac{t_p}{T}$$

$$V = \frac{t_p}{T}$$

SINUSOIDAL OPERATION

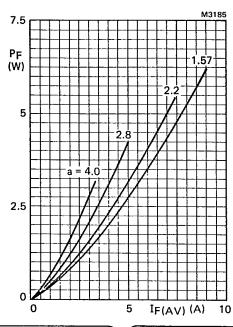
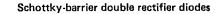


Fig.3 Forward current power rating; per diode.

 $a = form factor = I_F(RMS)/I_F(AV)$

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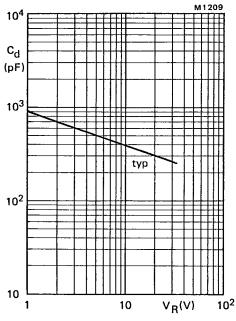


Fig.4 Typical junction capacitance at f = 1 MHz; per diode; $T_j = 25$ to 125 °C.

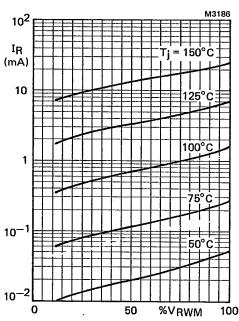


Fig.5 Typical values; per diode.

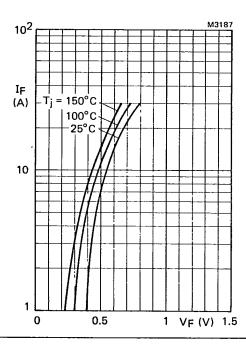


Fig.6 Typical forward voltage; per diode.

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